

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10572752	NAKAMURA ET AL.
Examiner	Art Unit	
Jennifer F Hu	4158	

SEARCHED			
Class	Subclass	Date	Examiner
343	788	11/13/2007	Jennifer F. Chang
343	787	11/19/2008	Jennifer F. Chang

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST Search History	11/13/2007	Jennifer F. Chang	
Inventor Search in eDAN	11/13/2007	Jennifer F. Chang	
EAST Search History	6/5/2008	Jennifer F. Chang	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/JENNIFER F HU/
Examiner Art Unit 2821